

Notice of References Cited

Application/Control No.

09/722,380

Applicant(s)/Patent Under

Reexamination

VAN HOOK ET AL.

Examiner

Hau H Nguyen

Art Unit

2676

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,664,955	12-2003	Deering, Michael F.	345/418
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	C	US-			
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	K	US-			
	L	US-			
	M	US-			

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